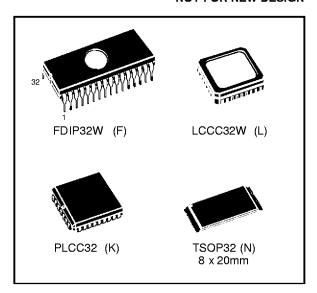


### M27V401

# LOW VOLTAGE 4 Megabit (512K x 8) UV EPROM and OTP EPROM

#### **NOT FOR NEW DESIGN**

- LOW VOLTAGE READ OPERATION: 3V to 5.5V
- FAST ACCESS TIME: 120ns
- LOW POWER "CMOS" CONSUMPTION:
  - Active Current 15mA
  - Standby Current 20μA
- PROGRAMMING VOLTAGE: 12.75V
- PROGRAMMING TIMES of AROUND 48sec. (PRESTO II ALGORITHM)
- M27V401 is PROGRAMMABLE as M27C4001 with IDENTICAL SIGNATURE
- M27V401 is replaced by the M27W401



#### **DESCRIPTION**

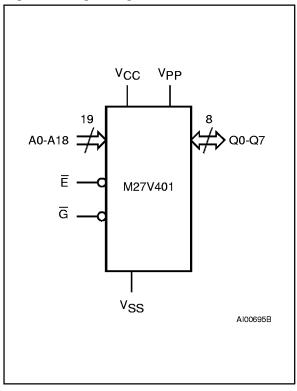
The M27V401 is a low voltage, low power 4 Megabit UV erasable and electrically programmable EPROM, ideally suited for handheld and portable microprocessor systems requiring large programs. It is organized as 524,288 by 8 bits.

The M27V401 operates in the read mode with a supply voltage as low as 3V. The decrease in operating power allows either a reduction of the size of the battery or an increase in the time between battery recharges.

Table 1. Signal Names

A0 - A18	Address Inputs
Q0 - Q7	Data Outputs
Ē	Chip Enable
G	Output Enable
V <sub>PP</sub>	Program Supply
V <sub>CC</sub>	Supply Voltage
V <sub>SS</sub>	Ground

Figure 1. Logic Diagram



March 1998 1/15

Figure 2A. DIP Pin Connections

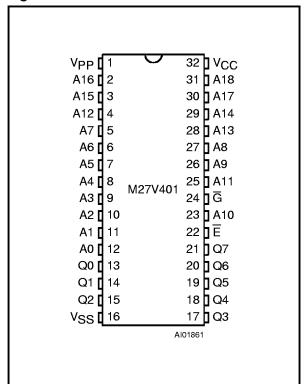


Figure 2B. LCC Pin Connections

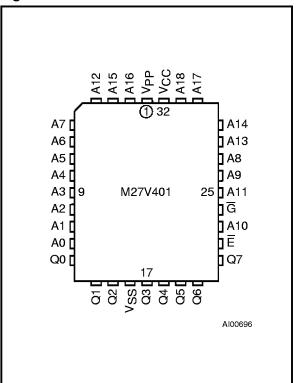
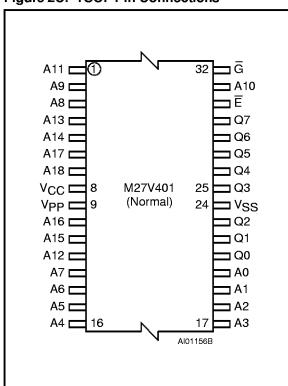


Figure 2C. TSOP Pin Connections



**DESCRIPTION** (cont'd)

The M27V401 can also be operated as a standard 4 Megabit EPROM (similar to M27C4001) with a 5V power supply.

The Window Ceramic Frit-Seal Dual-in-Line and Leadless Chip Carrier packages have transparent lids which allow the user to expose the chip to ultraviolet light to erase the bit pattern. A new pattern can then be written to the device by following the programming procedure. For applications where the content is programmed only one time and erasure is not required, the M27V401 is offered in both Plastic Leaded Chip Carrier and Plastic thin Small Outline packages.

#### **DEVICE OPERATION**

The modes of operation of the M27V401 are listed in the Operating Modes table. A single power supply is required in the read mode. All inputs are TTL levels except for  $V_{PP}$  and 12V on A9 for Electronic Signature.

#### **Read Mode**

The M27V401 has two control functions, both of which must be logically active in order to obtain data at the outputs. Chip Enable  $(\overline{E})$  is the power control and should be used for device selection.

Table 2. Absolute Maximum Ratings (1)

Symbol	Parameter	Value	Unit
T <sub>A</sub>	Ambient Operating Temperature	-40 to 125	°C
T <sub>BIAS</sub>	Temperature Under Bias	–50 to 125	°C
T <sub>STG</sub>	Storage Temperature	–65 to 150	°C
V <sub>IO</sub> (2)	Input or Output Voltages (except A9)	–2 to 7	V
V <sub>CC</sub>	Supply Voltage	–2 to 7	V
V <sub>A9</sub> <sup>(2)</sup>	A9 Voltage	–2 to 13.5	V
V <sub>PP</sub>	Program Supply Voltage	–2 to 14	V

Notes: 1. Except for the rating "Operating Temperature Range", stresses above those listed in the Table "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the SGS-THOMSON SURE Program and other relevant quality documents.

2. Minimum DC voltage on Input or Output is -0.5V with possible undershoot to -2.0V for a period less than 20ns. Maximum DC voltage on Output is Vcc +0.5V with possible overshoot to Vcc +2V for a period less than 20ns.

Table 3. Operating Modes

Mode	Ē	G	<b>A</b> 9	V <sub>PP</sub>	Q0 - Q7
Read	V <sub>IL</sub>	V <sub>IL</sub>	Х	V <sub>CC</sub> or V <sub>SS</sub>	Data Out
Output Disable	V <sub>IL</sub>	V <sub>IH</sub>	×	V <sub>CC</sub> or V <sub>SS</sub>	Hi-Z
Program	V <sub>IL</sub> Pulse	V <sub>IH</sub>	Х	V <sub>PP</sub>	Data In
Verify	V <sub>IH</sub>	V <sub>IL</sub>	Х	V <sub>PP</sub>	Data Out
Program Inhibit	V <sub>IH</sub>	VIH	Х	V <sub>PP</sub>	Hi-Z
Standby	V <sub>IH</sub>	Х	Х	V <sub>CC</sub> or V <sub>SS</sub>	Hi-Z
Electronic Signature	V <sub>IL</sub>	V <sub>IL</sub>	V <sub>ID</sub>	V <sub>CC</sub>	Codes

**Note**:  $X = V_{IH} \text{ or } V_{IL}, V_{ID} = 12V \pm 0.5V$ 

Table 4. Electronic Signature

Identifier	A0	Q7	Q6	<b>Q</b> 5	Q4	Q3	Q2	Q1	Q0	Hex Data
Manufacturer's Code	V <sub>IL</sub>	0	0	1	0	0	0	0	0	20h
Device Code	V <sub>IH</sub>	0	1	0	0	0	0	0	1	41h

Output Enable ( $\overline{G}$ ) is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that the addresses are stable, the address access time ( $t_{AVQV}$ ) is equal to the delay from  $\overline{E}$  to output ( $t_{ELQV}$ ). Data is available at the output after a delay of  $t_{GLQV}$  from the falling edge of  $\overline{G}$ , assuming that  $\overline{E}$  has been low and the addresses have been stable for at least  $t_{AVQV}$ - $t_{GLQV}$ .

#### Standby Mode

The M27V401 has a standby mode which reduces the active current from 15mA to  $20\mu A$  with low voltage operation  $V_{CC} \le 3.2V$  (30mA to  $100\mu A$  with a supply of 5.5V), see Read Mode DC Characteristics Table for details. The M27V401 is placed in the standby mode by applying a CMOS high signal to the E input. When in the standby mode, the outputs are in a high impedance state, independent of the  $\overline{G}$  input.

Table 5. AC Measurement Conditions

	High Speed	Standard
Input Rise and Fall Times	≤10ns	≤ 20ns
Input Pulse Voltages	0 to 3V	0.4V to 2.4V
Input and Output Timing Ref. Voltages	1.5V	0.8V and 2V

Figure 3. AC Testing Input Output Waveform

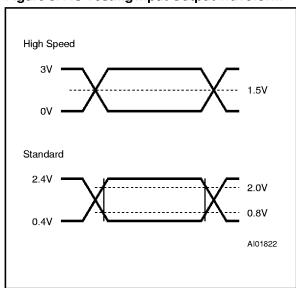


Figure 4. AC Testing Load Circuit

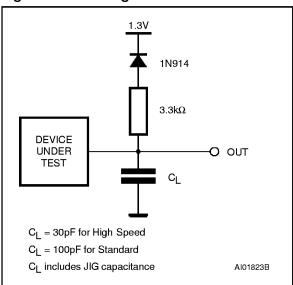


Table 6. Capacitance (1)  $(T_A = 25 \, ^{\circ}C, f = 1 \, \text{MHz})$ 

Symbol	Parameter	Test Condition	Min	Max	Unit
C <sub>IN</sub>	Input Capacitance	$V_{IN} = 0V$		6	pF
C <sub>OUT</sub>	Output Capacitance	V <sub>OUT</sub> = 0V		12	pF

Note: 1. Sampled only, not 100% tested.

#### **Two Line Output Control**

Because EPROMs are usually used in larger memory arrays, this product features a 2 line control function which accommodates the use of multiple memory connection. The two line control function allows:

- a. the lowest possible memory power dissipation,
- b. complete assurance that output bus contention will not occur.

For the most efficient use of these two control lines, E should be decoded and used as the primary device selecting function, while G should be made a common connection to all devices in the array and connected to the READ line from the system control bus. This ensures that all deselected memory devices are in their low power standby mode and that the output pins are only active when data is required from a particular memory device.

Table 7. Read Mode DC Characteristics  $^{(1)}$  (TA = 0 to 70 °C or -40 to 85 °C; VCC = 3.3V  $\pm$  10%; VPP = VCC)

Symbol	Parameter	Test Condition	Min	Max	Unit
I <sub>LI</sub>	Input Leakage Current	$0V \le V_{IN} \le V_{CC}$		±10	μА
I <sub>LO</sub>	Output Leakage Current	$0V \le V_{OUT} \le V_{CC}$		±10	μА
Icc	Supply Current	$\overline{E} = V_{IL}, \overline{G} = V_{IL}, I_{OUT} = 0mA, \\ f = 5MHz, V_{CC} \le 3.2V$		15	mA
ICC	Сарру Сансти	$\overline{E}$ = V <sub>IL</sub> , $\overline{G}$ = V <sub>IL</sub> , I <sub>OUT</sub> = 0mA, f = 5MHz, V <sub>CC</sub> = 5.5V		30	mA
lcc <sub>1</sub>	Supply Current (Standby) TTL	$\overline{E} = V_IH$		1	mA
I <sub>CC2</sub>	Supply Current (Standby)	$\overline{E}$ > $V_{CC}$ - 0.2V, $V_{CC} \le 3.2V$		20	μА
1002	CMOS	$\overline{E} > V_{CC} - 0.2V, V_{CC} = 5.5V$		100	μА
I <sub>PP</sub>	Program Current	$V_{PP} = V_{CC}$		10	μА
V <sub>IL</sub>	Input Low Voltage		-0.3	0.8	٧
V <sub>IH</sub> <sup>(2)</sup>	Input High Voltage		2	V <sub>CC</sub> + 1	٧
V <sub>OL</sub>	Output Low Voltage	$I_{OL} = 2.1 \text{mA}$		0.4	٧
V <sub>OH</sub>	Output High Voltage TTL	I <sub>OH</sub> = -400μA	2.4		V
↓ VOH	Output High Voltage CMOS	$I_{OH} = -100\mu A$	V <sub>CC</sub> - 0.7V		٧

Notes: 1. V<sub>CC</sub> must be applied simultaneously with or before V<sub>PP</sub> and removed simultaneously or after V<sub>PP</sub>.

2. Maximum DC voltage on Output is V<sub>CC</sub> +0.5V

Table 8A. Read Mode AC Characteristics  $^{(1)}$  (T<sub>A</sub> = 0 to 70°C or –40 to 85°C; V<sub>CC</sub> = 3.3V  $\pm$  10%; V<sub>PP</sub> = V<sub>CC</sub>)

				M27V401				
Symbol	Alt	Parameter	Test Condition	Test Condition -120 (3)		-1	50	Unit
				Min	Max	Min	Max	
t <sub>AVQV</sub>	t <sub>ACC</sub>	Address Valid to Output Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$		120		150	ns
t <sub>ELQV</sub>	t <sub>CE</sub>	Chip Enable Low to Output Valid	$\overline{G} = V_{IL}$		120		150	ns
t <sub>GLQV</sub>	t <sub>OE</sub>	Output Enable Low to Output Valid	$\overline{E} = V_{IL}$		60		80	ns
t <sub>EHQZ</sub> (2)	t <sub>DF</sub>	Chip Enable High to Output Hi-Z	$\overline{G} = V_{IL}$	0	50	0	50	ns
t <sub>GHQZ</sub> (2)	t <sub>DF</sub>	Output Enable High to Output Hi-Z	$\overline{E} = V_{IL}$	0	50	0	50	ns
t <sub>AXQX</sub>	t <sub>OH</sub>	Address Transition to Output Transition	$\overline{E} = V_{ L}, \overline{G} = V_{ L}$	0		0		ns

Notes: 1. Vcc must be applied simultaneously with or before Vpp and removed simultaneously or after Vpp. 2. Sampled only, not 100% tested.
3. In case of 120ns speed see High Speed AC Measurement conditions.

Table 8B. Read Mode AC Characteristics (1)

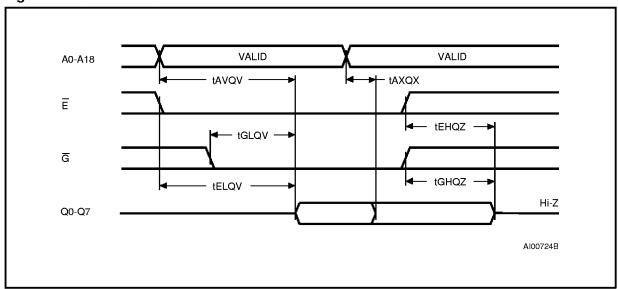
 $(T_A = 0 \text{ to } 70^{\circ}\text{C or } -40 \text{ to } 85^{\circ}\text{C}; V_{CC} = 3.3\text{V} \pm 10\%; V_{PP} = V_{CC})$ 

	Alt	Parameter	Test Condition					
Symbol	^"	i didilicici	rest condition	-180		-2	00	Unit
				Min	Max	Min	Max	
t <sub>AVQV</sub>	t <sub>ACC</sub>	Address Valid to Output Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$		180		200	ns
t <sub>ELQV</sub>	t <sub>CE</sub>	Chip Enable Low to Output Valid	$\overline{G} = V_{IL}$		180		200	ns
t <sub>GLQV</sub>	t <sub>OE</sub>	Output Enable Low to Output Valid	$\overline{E} = V_{IL}$		90		100	ns
t <sub>EHQZ</sub> (2)	t <sub>DF</sub>	Chip Enable High to Output Hi-Z	$\overline{G} = V_{IL}$	0	50	0	70	ns
t <sub>GHQZ</sub> <sup>(2)</sup>	t <sub>DF</sub>	Output Enable High to Output Hi-Z	$\overline{E} = V_{IL}$	0	50	0	70	ns
t <sub>AXQX</sub>	t <sub>OH</sub>	Address Transition to Output Transition	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	0		0		ns

Notes: 1. Vcc must be applied simultaneously with or before VPP and removed simultaneously or after VPP.

2. Sampled only, not 100% tested

Figure 5. Read Mode AC Waveforms



#### **System Considerations**

The power switching characteristics of Advanced CMOS EPROMs require careful decoupling of the devices. The supply current, Icc, has three segments that are of interest to the system designer: the standby current level, the active current level, and transient current peaks that are produced by the falling and rising edges of  $\overline{E}$ . The magnitude of the transient current peaks is dependent on the capacitive and inductive loading of the device at the output.

The associated transient voltage peaks can be suppressed by complying with the two line output

control and by properly selected decoupling capacitors. It is recommended that a  $0.1\mu F$  ceramic capacitor be used on every device between  $V_{\rm CC}$  and  $V_{\rm SS}$ . This should be a high frequency capacitor of low inherent inductance and should be placed as close to the device as possible. In addition, a  $4.7\mu F$  bulk electrolytic capacitor should be used between  $V_{\rm CC}$  and  $V_{\rm SS}$  for every eight devices. The bulk capacitor should be located near the power supply connection point. The purpose of the bulk capacitor is to overcome the voltage drop caused by the inductive effects of PCB traces.

Table 9. Programming Mode DC Characteristics  $^{(1)}$  (TA = 25 °C; VCC = 6.25V  $\pm$  0.25V; VPP = 12.75V  $\pm$  0.25V)

Symbol	Parameter	Test Condition	Min	Max	Unit
ILI	Input Leakage Current	$V_{IL} \leq V_{IN} \leq V_{IH}$		±10	μΑ
lcc	Supply Current			50	mA
I <sub>PP</sub>	Program Current	E = V <sub>IL</sub>		50	mA
V <sub>IL</sub>	Input Low Voltage		-0.3	0.8	٧
$V_{IH}$	Input High Voltage		2	V <sub>CC</sub> + 0.5	٧
$V_{OL}$	Output Low Voltage	I <sub>OL</sub> = 2.1mA		0.4	V
V <sub>OH</sub>	Output High Voltage TTL	I <sub>OH</sub> = -400μA	2.4		V
V <sub>ID</sub>	A9 Voltage		11.5	12.5	٧

Note: 1. V<sub>CC</sub> must be applied simultaneously with or before V<sub>PP</sub> and removed simultaneously or after V<sub>PP</sub>.

## Table 10. Programming Mode AC Characteristics $^{(1)}$ (TA = 25 °C; VCC = $6.25V\pm0.25V; V_{PP}$ = $12.75V\pm0.25V)$

Symbol	Alt	Parameter	Test Condition	Min	Max	Unit
t <sub>AVPL</sub>	t <sub>AS</sub>	Address Valid to Program Low		2		μs
t <sub>QVPL</sub>	t <sub>DS</sub>	Input Valid to Program Low		2		μs
t <sub>VPHPL</sub>	t <sub>VPS</sub>	V <sub>PP</sub> High to Program Low		2		μs
t <sub>VCHPL</sub>	tvcs	V <sub>CC</sub> High to Program Low		2		μs
t <sub>ELPL</sub>	t <sub>CES</sub>	Chip Enable Low to Program Low		2		μs
t <sub>PLPH</sub>	t <sub>PW</sub>	Program Pulse Width		95	105	μs
t <sub>PHQX</sub>	t <sub>DH</sub>	Program High to Input Transition		2		μs
t <sub>QXGL</sub>	t <sub>OES</sub>	Input Transition to Output Enable Low		2		μs
tGLQV	toE	Output Enable Low to Output Valid			100	ns
t <sub>GHQZ</sub> (2)	t <sub>DFP</sub>	Output Enable High to Output Hi-Z		0	130	ns
tghax	t <sub>AH</sub>	Output Enable High to Address Transition		0		ns

Notes: 1. V<sub>CC</sub> must be applied simultaneously with or before V<sub>PP</sub> and removed simultaneously or after V<sub>PP</sub>. 2. Sampled only, not 100% tested..

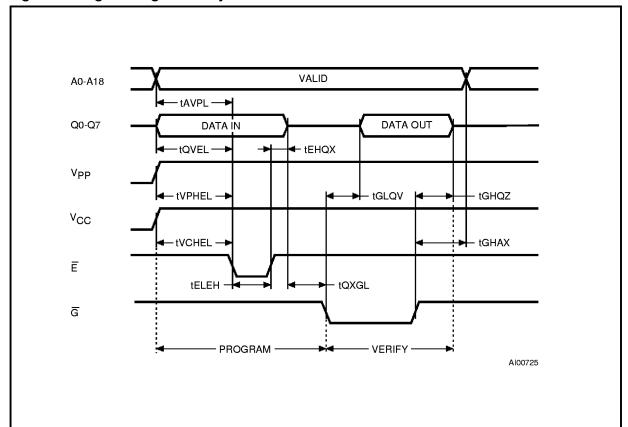


Figure 6. Programming and Verify Modes AC Waveforms

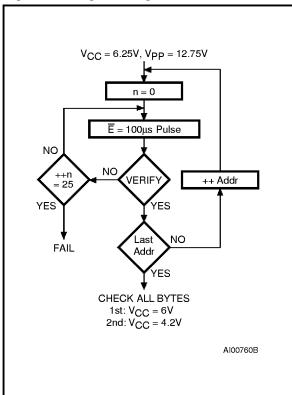
#### **Programming**

The M27V401 has been designed to be fully compatible with the M27C4001. As a result the M27V401 can be programmed as the M27C4001 on the same programmers applying 12.75V on  $V_{PP}$  and 6.25V on  $V_{CC}.$  The M27V401 has the same electronic signature and uses the same PRESTO II algorithm .

When delivered (and after each erasure for UV EPROM), all bits of the M27V401 are in the "1" state. Data is introduced by selectively program-

ming "0"s into the desired bit locations. Although only "0"s will be programmed, both "1"s and "0"s can be present in the data word. The only way to change a "0" to a "1" is by die exposure to ultraviolet light (UV EPROM). The M27V401 is in the programming mode when  $V_{PP}$  input is at 12.75V, G at  $V_{IH}$  and E is pulsed to  $V_{IL}$ . The data to be programmed is applied to 8 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL.  $V_{CC}$  is specified to be 6.25V  $\pm$  0.25V.

Figure 7. Programming Flowchart



#### **PRESTO II Programming Algorithm**

PRESTO II Programming Algorithm allows the whole array to be programmed, with a guaranteed margin, in a typical time of 52.5 seconds. Programming with PRESTO II involves in applying a sequence of 100µs program pulses to each byte until a correct verify occurs (see Figure 7). During programming and verify operation, a MARGIN MODE circuit is automatically activated in order to guarantee that each cell is programmed with enough margin. No overprogram pulse is applied since the verify in MARGIN MODE provides necessary margin to each programmed cell.

#### **Program Inhibit**

Programming of multiple M27V401s in parallel with different data is also easily accomplished. Except for  $\overline{E}$ , all like inputs including  $\overline{G}$  of the parallel M27V401 may be common. A TTL low level pulse applied to a M27V401's  $\overline{E}$  input with V<sub>PP</sub> at 12.75V, will program that M27V401. A high level  $\overline{E}$  input inhibits the other M27V401s from being programmed.

#### **Program Verify**

A verify (read) should be performed on the programmed bits to determine that they were correctly programmed. The verify is accomplished with  $\overline{G}$  at  $V_{IL}$ ,  $\overline{E}$  at  $V_{IH}$ ,  $V_{PP}$  at 12.75V and  $V_{CC}$  at 6.25V.

#### **On-Board Programming**

The M27V401 can be directly programmed in the application circuit. See the relevant Application Note AN620.

#### **Electronic Signature**

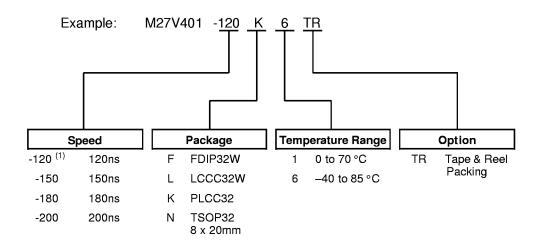
The Electronic Signature (ES) mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment to automatically match the device to be programmed with its corresponding programming algorithm. The ES mode is functional in the  $25^{\circ}C \pm 5^{\circ}C$  ambient temperature range that is required when programming the M27V401. To activate the ES mode, the programming equipment must force 11.5V to 12.5V on address line A9 of the M27V401, with  $V_{PP} = V_{CC} = 5V$ . Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from  $V_{IL}$  to  $V_{IH}$ . All other address lines must be held at  $V_{IL}$  during Electronic Signature mode.

Byte 0 ( $A0=V_{IL}$ ) represents the manufacturer code and byte 1 ( $A0=V_{IH}$ ) the device identifier code. For the SGS-THOMSON M27V401, these two identifier bytes are given in Table 4 and can be read-out on outputs Q0 to Q7. Note that the M27V401 and M27C4001 have the same identifier bytes.

#### **ERASURE OPERATION (applies to UV EPROM)**

The erasure characteristics of the M27V401 is such that erasure begins when the cells are exposed to light with wavelengths shorter than approximately 4000Å. It should be noted that sunlight and some type of fluorescent lamps have wavelengths in the 3000-4000 Årange. Research shows that constant exposure to room level fluorescent lighting could erase a typical M27V401 in about 3 years, while it would take approximately 1 week to cause erasure when exposed to direct sunlight. If the M27V401 is to be exposed to these types of lighting conditions for extended periods of time, it is suggested that opaque labels be put over the M27V401 window to prevent unintentional erasure. The recommended erasure procedure for the M27V401 is exposure to short wave ultraviolet light which has a wavelength of 2537Å. The integrated dose (i.e. UV intensity x exposure time) for erasure should be a minimum of 15 W-sec/cm<sup>2</sup>. The erasure time with this dosage is approximately 15 to 20 minutes using an ultraviolet lamp with 12000 μW/cm<sup>2</sup> power rating. The M27V401 should be placed within 2.5 cm (1 inch) of the lamp tubes during the erasure. Some lamps have a filter on their tubes which should be removed before erasure.

### **ORDERING INFORMATION SCHEME**



Note: 1. High Speed, see AC Characteristics section for further information.

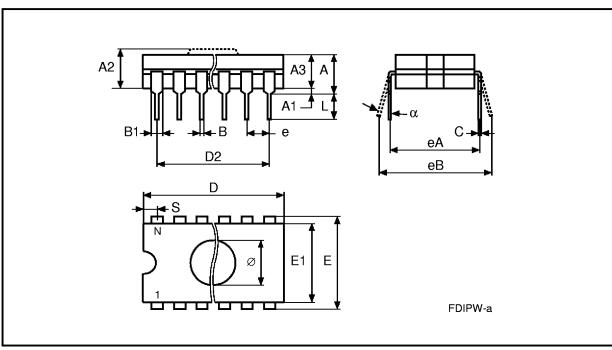
The M27V401 is replaced by the new version M27W401.

For a list of available options (Speed, Package, Temperature Range, etc...) refer to the current Memory Shortform catalogue.

For further information on any aspect of this device, please contact the SGS-THOMSON Sales Office nearest to you.

## FDIP32W - 32 pin Ceramic Frit-seal DIP, with window

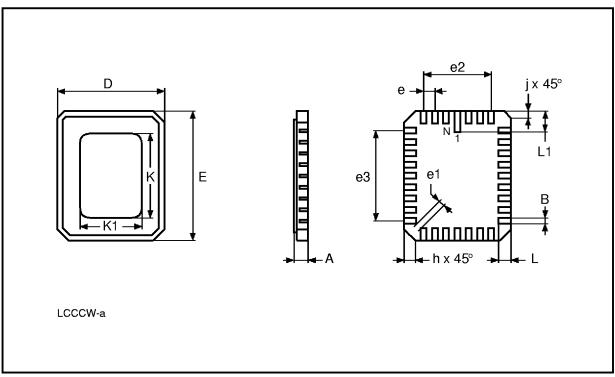
Symb		mm			inches	
Зушь	Тур	Min	Max	Тур	Min	Max
Α			5.72			0.225
<b>A</b> 1		0.51	1.40		0.020	0.055
A2		3.91	4.57		0.154	0.180
A3		3.89	4.50		0.153	.0177
В		0.41	0.56		0.016	0.022
B1	1.45	_	_	0.057	_	_
С		0.23	0.30		0.009	0.012
D		41.73	42.04		1.643	1.655
D2	38.10	_	_	1.500	-	_
E	15.24	-	_	0.600	-	_
E1		13.06	13.36		0.514	0.526
е	2.54	-	-	0.100	-	_
eA	14.99	_	_	0.590	-	_
eB		16.18	18.03		0.637	0.710
L		3.18			0.125	
S		1.52	2.49		0.060	0.098
Ø	7.11	_	_	0.280	-	-
α		4°	11°		4°	11°
N		32			32	



Drawing is not to scale.

## LCCC32W - 32 lead Leadless Ceramic Chip Carrier, with window

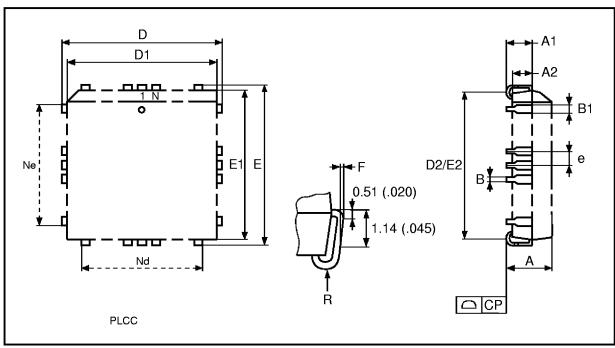
Symb	mm			inches		
	Тур	Min	Max	Тур	Min	Max
Α			2.28			0.090
В		0.51	0.71		0.020	0.028
D		11.23	11.63		0.442	0.458
Е		13.72	14.22		0.540	0.560
е	1.27	_	-	0.050	-	_
e1		0.39	-		0.015	_
e2	7.62	_	_	0.300	_	-
e3	10.16	_	-	0.400	-	1
h	1.02	_	_	0.040	-	-
j	0.51	_	_	0.020	_	_
L		1.14	1.40		0.045	0.055
L1		1.96	2.36		0.077	0.093
K		10.50	10.80		0.413	0.425
K1		8.03	8.23		0.316	0.324
N	32			32		



Drawing is not to scale.

## PLCC32 - 32 lead Plastic Leaded Chip Carrier, rectangular

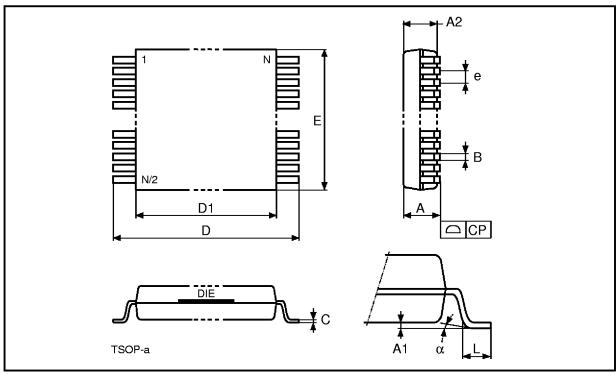
Symb	mm			inches			
	Тур	Min	Max	Тур	Min	Мах	
А		2.54	3.56		0.100	0.140	
A1		1.52	2.41		0.060	0.095	
A2		_	0.38		_	0.015	
В		0.33	0.53		0.013	0.021	
B1		0.66	0.81		0.026	0.032	
D		12.32	12.57		0.485	0.495	
D1		11.35	11.56		0.447	0.455	
D2		9.91	10.92		0.390	0.430	
E		14.86	15.11		0.585	0.595	
E1		13.89	14.10		0.547	0.555	
E2		12.45	13.46		0.490	0.530	
е	1.27	_	_	0.050	_	_	
F		0.00	0.25		0.000	0.010	
R	0.89	_	_	0.035	_	_	
N	32			32			
Nd	7			7			
Ne	9			9			
CP			0.10			0.004	



Drawing is not to scale.

TSOP32 - 32 lead Plastic Thin Small Outline, 8 x 20mm

Symb	mm			inches		
	Тур	Min	Max	Тур	Min	Max
Α			1.20			0.047
A1		0.05	0.17		0.002	0.006
A2		0.95	1.05		0.037	0.041
В		0.15	0.27		0.006	0.011
С		0.10	0.21		0.004	0.008
D		19.80	20.20		0.780	0.795
D1		18.30	18.50		0.720	0.728
E		7.90	8.10		0.311	0.319
е	0.50	_	_	0.020	-	-
L		0.50	0.70		0.020	0.028
α		0°	5°		0°	5°
N	32			32		
CP			0.10			0.004



Drawing is not to scale.